## Search Notes



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Application/Control No.	Applicant(s)/Patent und Reexamination
10/764 405	CHEN ET AL

 10/764,405
 CHEN ET AL.

 Examiner
 Art Unit

 DEANNA K. HALL
 3767

SEARCHED				
Class	Subclass	Date	Examiner	
604	523	7/18/2007	DKH	
604	96.01	7/19/2007	DKH	
604	103	1/7/2008	DKH	
604	103.05	1/7/2008	DKH	
604	103.06	1/7/2008	DKH	
604	915	1/7/2008	DKH	
606	191	1/7/2008	DKH	
606	192	1/7/2008	DKH	
606	194	1/7/2008	DKH	
606	108	1/7/2008	DKH	
428	35.2	1/7/2008	DKH	
428	35.7	1/7/2008	DKH	

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
IDS	7/18/2007	DKH	
East	7/18/2007	DKH	
East inventor search	1/7/2008	DKH	
updated search	1/7/2008	DKH	
updated search	3/18/2008	DKH	
updated search	9/22/2008	DKH	
updated search	4/30/2009	DKH	
updated search	1/19/2010	DKH	